

MAY 21 2002

SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 213160US0		SERIAL NO. 09/939,811	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Seijo TANIMOTO, et al.			
				FILING DATE 08/28/01		GROUP 1714	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
✓	AA	5,900,463	05/04/99	TANIMOTO, et al.			
✓	AB	6,156,840	12/05/00	NAKAMAE, et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner Tae H Yoon					Date Considered 9-23-03		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



SHEET 1 OF 1

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Seiji TANIMOTO, et al.			
				FILING DATE August 28, 2001		GROUP 1714	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	11-21380	01/28/99	JAPAN			X
	AP	63-46252	02/27/88	JAPAN			X
	AQ	64-62347	03/08/89	JAPAN			X
	AR	11-21529	01/26/99	JAPAN			X
	AS	10-226774	08/25/98	JAPAN			X
	AT						
	AU						
	AV						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>Tae H. Yoon</i>				Date Considered <i>8-27-03</i>			
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